High Power Button Capsule Thyristor

#### DCR1003 Series DCR1004 Series I<sub>T(AV) = 1540A</sub> V<sub>RRM = 1700V</sub>

	Туре	Non-Repetitive	Repetitive	OUTLINE N
	Number	Peak Voltages	Peak Voltages	OUTLINE N
DCR100	3SN1818 DCR1004SN1818	1800	1700.	Ø73.5 MAX (INCL GLAZE)
DCR1003SN1717 DCR1004SN1717 1700		1600.		
DCR1003SN1616 DCR1004SN1616 1600		1500.		
DCR100	3SN1515 DCR1004SN1515	1500	1400.	
DCR1003SN1414 DCR1004SN1414 1400		1300.		
	DCR1003SN1313 DCR1004SN1313 1300		1200.	
	DCR1003SN1212 DCR1004SN1212 1200		1100.	
DCR1003SN1111 DCR1004SN1111 1100		1000.		
DCR1003SN1010 DCR1004SN1010 1000		900.		
DCR1003SN0909 DCR1004SN0909 900		800. 700.	ANODE 47.0	
DCR1003SN0808 DCR1004SN0808 800 DCR1003SN0707 DCR1004SN0707 700		600.	048.7	
		600	500.	
	DCR1003SN0505 DCR1004SN0505 500		400.	Weight 530 g Minimum clemning force 18.0 kN
DCR1003SN0404 DCR1004SN0404 400		400	300.	Minimum clamping force 18.0 kN Maximum clamping force 22.0 kN
DCR100	DCR1003SN0303 DCR1004SN0303 300		200.	autonumentenum (STARTE) Destate et al.
DCR100	3SN0202 DCR1004SN0202	200	150.	• n
DCR100	3SN0101 DCR1004SN0101	100	75.	
	ATINGS— DOUBLE SIDE COOLED			
	Mean on-state current		Half wave	resistive load T <sub>HS</sub> = 55°C 1540 A
	RMS value		T <sub>HS</sub> = 55°C	2420 A
I <sub>T</sub>	Continuous (direct) on-state current		т <sub>нs</sub> = 55°С Т <sub>нs</sub> = 55°С	2050 A
R <sub>(th(J-h)</sub>	Thermal resistance junction to			force 19.5kN d.c026°C/W
(	heatsink surface			nting grease) Half-wave .028°C/W
				3-phase .030°C/W
CURRENT R	ATINGS—SINGLE SIDE COOLED			
I <sub>T(AV)</sub>	Mean on-state current			resistive load T <sub>HS</sub> = 55°C 870 A
I <sub>RMS</sub>	RMS value		T <sub>HS</sub> = 55°C	1365 A
IT	Continuous (direct) on-state current		T <sub>HS</sub> = 55°C	1060 A
R <sub>(th(J-h)</sub>				force 19.5kN d.c06°C/W
	heatsink surface		(with mot	nting grease) Half-wave .062°C/W
SURGE RAT	INGS			3-phase .064°C/W
ITRM	Repetitive peak on-state current	t	Sinusoida	waveform conduction angle 14920 A
•1KM	הפיבונויע ויישנע טוישנעני נעוופוונ		+ = 30° Τ <sub>ι</sub>	-
l²t	I <sup>2</sup> t for fusing			sine T <sub>1</sub> = 125°C 2205000 A <sup>2</sup> sec
				ine T <sub>1</sub> = 125°C 1540000 A <sup>2</sup> sec
I <sub>TSM</sub>	Surge (non-repetitive) on-state of	current	With 50%	V <sub>RSM</sub> TJ = 125°C 21000 A
dl₁/dt	t Rate of rise of on-state current			ο 1000A, Gate source 10V 100A/μs
				ne 0.5μs, Τ <sub>1</sub> = 125°C
dv/dt*	Max linear rate of rise of off-stat	te voltage	Voltage =	67%V <sub>DRM</sub> , T <sub>case</sub> = 125°C 300 V/ μs
*Higher val	ues available.			
GATE RATIN	NGS			
V <sub>FGM</sub>	Peak forward gate voltage		Anode po	sitive with respect to cathode 30 V
V <sub>FGN</sub>	Peak forward gate voltage		Anode ne	gative with respect to cathode 0.25 V
V <sub>RGM</sub>	Peak reverse gate voltage			5 V
I <sub>FGM</sub>	-		-	itive with respect to cathode 10 A
P <sub>GM</sub> Peak gate power		Pulse wid	-	
P <sub>G</sub>	Mean gate power			10 W
	URE & FREQUENCY RATINGS			apr <sup>0</sup> c
T <sub>v</sub>	Virtual junction temperature		On-state ( Off-state	conduction) 135°C blocking) 125°C
т	Storage temperature range		Uff-state	blocking) 125°C -55 to 125°C
T <sub>stg</sub> F	Storage temperature range Frequency range			-55 to 125 C 10 to 400 Hz
L .	inclusion ange			10 10 400 12

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## DCR1003 Series

DCR1004 Series I<sub>T(AV)</sub> = 1540 A

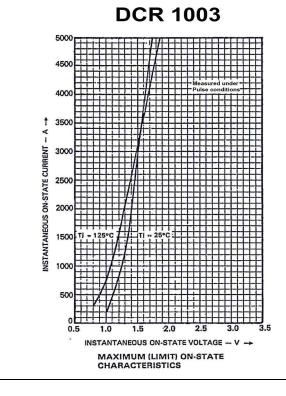
V<sub>RRM</sub> = 1700 V

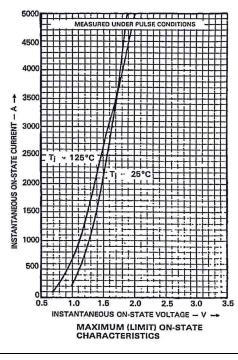


CHARACTERISTICS— $T_{case} = 25^{\circ}C$ unless otherwise stated					LIMIT				
				5%	Тур	95%	Max	Units	
VTM	On-state voltage	At 2900A peak	DCR 1003				1.5	v	
			DCR1004				1.625	v	
I <sub>DM</sub>	Peak off-state current	$T_{case} = 125^{\circ}C$					50	mA	
I <sub>RM</sub>	Peak reverse current	$T_{case} = 125^{\circ}C$					50	mA	
I.	Latching current	$V_D = 5V T_p = 30 \mu S$			120			mA	
I <sub>H</sub>	Holding current	V <sub>D</sub> = 5V Gate open circuit			77			mA	
td	Delay time	V <sub>D</sub> = 100V, Gate source = 25V	5Ω	0.58	0.8	1.52		μs	
tq	Circuit commutated	$I_{T}$ = 800A, $V_{RRM}$ = 50V, $dI_{RR}/dt$	= 20A/μS	90	215	380		μs	
	Turn-off time	$V_{DR}$ = full rated $V_{D}$ ,							
		dV <sub>DR</sub> /dt = 20V/μs linear , T <sub>case</sub> = 125°C							
V <sub>gt</sub>	Gate trigger voltage	V <sub>DRM</sub> = 5V					3.5	v	
$V_{\text{gd}}$	Gate non-trigger voltage	At V <sub>DRM</sub> , T <sub>case</sub> = 5V					0.25	v	
I <sub>GT</sub>	Gate trigger current	V <sub>DWM</sub> = 5V					200	mA	

# **DCR 1004**

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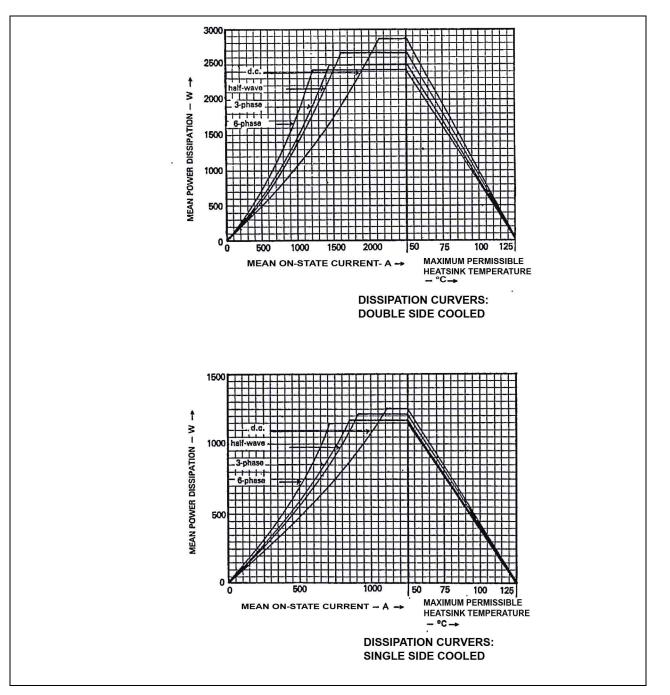
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DCR1003 Series DCR1004 Series I<sub>T(AV)</sub> = 1540 A V<sub>RRM</sub> = 1700 V T-25-21



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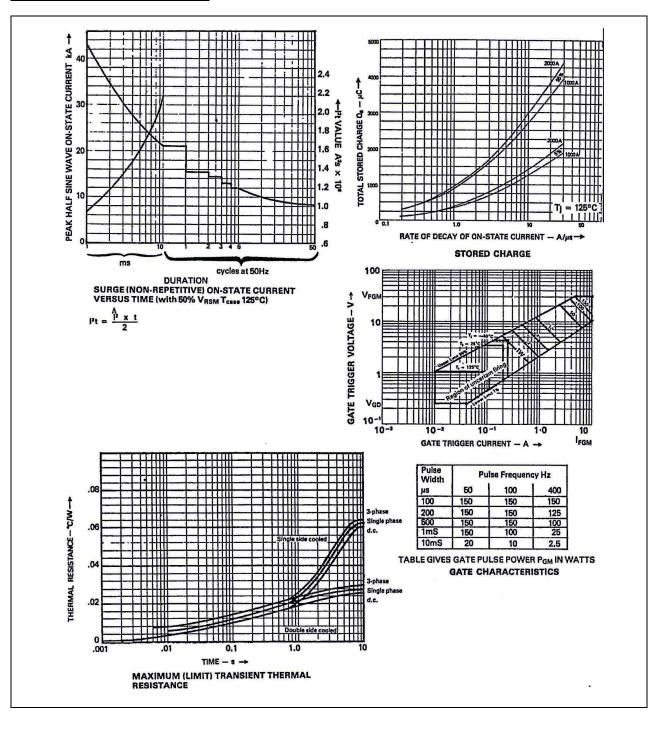
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## DCR1003 Series DCR1004 Series

I<sub>T(AV)</sub> = 1540 A

V<sub>RRM</sub> = 1700 V



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